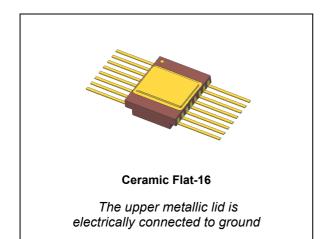


RHFLVDS31A

Rad-hard quad LVDS driver

Datasheet - production data



Features

- LVDS output
- CMOS input
- Enable/Disable function with high-impedance
- ANSI TIA/EIA-644 compliant
- 400 Mbps (200 MHz)
- · Cold spare on all pins
- 3.3 V operating power supply
- 4.8 V absolute rating
- Output voltage: 350 mV on 100-ohm load
- Power consumption: 55 mW at 3.3 V
- · Hermetic package

- Guaranteed up to 300 krad TID
- SEL immune up to 135 MeV.cm²/mg
- SET/SEU immune up to 67 MeV.cm²/mg

Description

The RHFLVDS31A is a quad, low-voltage, differential signaling (LVDS) driver specifically designed, packaged, and qualified for use in aerospace environments in a low-power and fast point-to-point baseband data transmission standard.

Operating at 3.3 V power supply, the RHFLVDS31A operates over a controlled impedance of 100-ohm transmission media that may be printed circuit board traces, back planes or cables.

The circuit features an internal fail-safe function to ensure a known state in case of floating input. All pins have cold spare buffers to ensure they are in high impedance when V_{CC} is tied to GND.

Designed on ST's proprietary CMOS process with specific mitigation techniques, the RHFLVDS31A achieves "best in the class" for hardness to total ionisation dose and heavy ions.

The RHFLVDS31A can operate over a large temperature range of -55 °C to +125 °C and it is housed in an hermetic Ceramic Flat-16 package.

Table 1. Device summary

Reference	SMD pin	Quality level	Package	Lead finish	Mass	EPPL ⁽¹⁾	Temp. range
RHFLVDS31AK1	-	Engineering model	Ceramic Flat-16	Gold	0.65 g	-	-55 °C to 125 °C
RHFLVDS31AK01V	5962F98651	QML-V flight	Flat-10			Target	125 0

1. EPPL = ESA preferred part list

Contents RHFLVDS31A

Contents

1	Functional description	. 3
2	Pin configuration	. 4
3	Maximum ratings and operating conditions	. 5
4	Radiation	. 6
5	Electrical characteristics	. 7
6	Test circuit	. 9
7	Package information	
8	Ordering information	13
9	Shipping information	13
10	Revision history	1⊿



1 Functional description

≥1 ΕN 12 G \triangleright ∇ 3 – 1Z ∇ - 2Y - 2Z <u>10</u> 3Y <u>10</u> 3Y 9 11 3Z <u>14</u> 4Y 15 <u>13</u> 4Z CS05860 CS05830

Figure 1. Logic diagram and logic symbol

Table 2. Truth table

Input	Enables		Out	puts
Α	G	G	Y	Z
Н	Н	Х	Н	L
L	Н	Х	L	Н
Н	Х	L	Н	L
L	Х	L	L	Н
X	L	Н	Z	Z
OPEN	Н	Х	L	Н
OPEN	Х	L	L	Н

Note: 1 The G input features an internal pull-up network. The \overline{G} input features an internal pull-down network. If they are floating the circuit is enabled.

2 L = low level, H = high Level, X = irrelevant, Z = high impedance (off)

Pin configuration RHFLVDS31A

2 Pin configuration

Figure 2. Pin connections (top view)

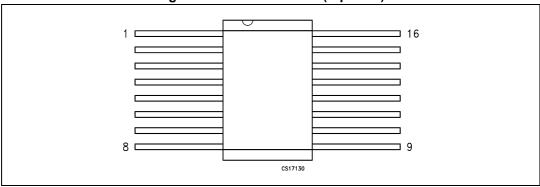


Table 3. Pin description

Pin number	Symbol	Name and function	
1, 7, 9, 15	1A to 4A	Driver inputs	
2, 6, 10, 14	1Y to 4Y	Driver eutrute	
3, 5, 11, 13	1Z to 4Z	Driver outputs	
4	G	Enable	
12	G	Ellable	
8	GND	Ground	
16	16 V _{CC} Supply voltage		

3 Maximum ratings and operating conditions

Absolute maximum ratings are those values beyond which damage to the device may occur. Functional operation under these conditions is not implied.

Table 4. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{CC}	Supply voltage ⁽¹⁾	4.8	
V _i	TTL inputs (operating or cold spare)	-0.3 to +4.8	V
V _{OUT}	LVDS outputs (operating or coldspare)	-0.3 to +4.8	
T _{stg}	Storage temperature range	-65 to +150	°C
T _j	Maximum junction temperature	+150	C
R _{thjc}	Thermal resistance junction to case ⁽²⁾	22	°C/W
	HBM: Human body model		
FOD	 All pins except LVDS outputs 	2	kV
ESD	- LVDS outputs vs. GND	8	
	CDM: Charge device model	500	V

^{1.} All voltages, except differential I/O bus voltage, are with respect to the network ground terminal.

Table 5. Operating conditions

Symbol	Parameter	Min.	Тур.	Max.	Unit
V _{CC}	Supply voltage	3	3.3	3.6	V
V _{IN}	Driver DC input voltage (TTL inputs)	0		3.6	V
T _A	Ambient temperature range	-55		+125	°C



Short-circuits can cause excessive heating. Destructive dissipation can result from short-circuits on the amplifiers.

Radiation RHFLVDS31A

4 Radiation

Total dose (MIL-STD-883 TM 1019)

The products guaranteed in radiation within the RHA QML-V system fully comply with the MIL-STD-883 TM 1019 specification.

The RHFLVDS31A is RHA QML-V, tested and characterized in full compliance with the MIL-STD-883 specification, between 50 and 300 rad/s only (full CMOS technology).

All parameters provided in *Table 7: Electrical characteristics* apply to both pre- and post-irradiation, as follows:

- All test are performed in accordance with MIL-PRF-38535 and test method 1019 of MIL-STD-883 for total ionizing dose (TID).
- The initial characterization is performed in qualification only on both biased and unbiased parts.
- Each wafer lot is tested at high dose rate only, in the worst bias case condition, based on the results obtained during the initial qualification.

Heavy ions

The behavior of the product when submitted to heavy ions is not tested in production. Heavy-ion trials are performed on qualification lots only.

Table 6. Radiation

Туре	Characteristics	Value	Unit
TID	High-dose rate (50 - 300 rad/sec) up to:	300	krad
	SEL immune up to: (with a particle angle of 60 ° at 125 °C)	135	
Heavy ions	SEL immune up to: (with a particle angle of 0 ° at 125 °C)	67	MeV.cm²/mg
	SET/SEU immune up to: (at 25 °C)	67	

5 Electrical characteristics

In *Table 7* below, V_{CC} = 3 V to 3.6 V, capa-load (CL) = 10 pF, typical values are at T_{amb} = +25 °C, min. and max values are at T_{amb} = -55 °C and + 125 °C unless otherwise specified

Table 7. Electrical characteristics

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{CCL}	Total enabled supply current, drivers enabled, not switching	V_{IN} = 0 V or V_{CC} Load = 100 Ω on all channels		16.5	20	
I _{CCZ}	Total disabled supply current, loaded or not loaded, drivers disabled			2.8	4	mA
I _{OFF} ⁽¹⁾	TTL input power-off leakage current	V _{CC} = 0 V, V _{IN} = 3.6 V	-10		10	
OFF `	LVDS output power-off leakage current	V _{CC} = 0 V, V _{OUT} = 3.6 V	-50		+50	μΑ
V _{OH}	Output voltage high				1.65	V
V _{OL}	Output voltage low		0.925			V
V _{OD1}	Differential output voltage		250		400	
DV _{OD1}	Change of magnitude of V _{OD1} for complementary output states	R _L = 100 Ω			10	mV
V _{OS}	Offset voltage		1.125		1.45	V
DV _{OS}	Change of magnitude of V _{OS} for complementary output states				15	mV
I _{OS}	Output short-circuit current	$V_{IN} = 0 \text{ V}$ and $V_{O(Z)} = 0 \text{ V}$ or $V_{IN} = V_{CC}$ and $V_{O(Y)} = 0 \text{ V}$	-9			mA
I _O	High impedance output current	Disabled, V _{OUT} = 3.6 V or GND	-10		10	μA
V _{IH}	Input voltage high	G, G, and TTL inputs	2		V_{CC}	V
V _{IL}	Input voltage low	G, G, and TTE inputs	GND		0.8	V
I _{IH}	High level input current	$G, \overline{G}, \text{ and TTL inputs}$ $V_{CC} = 3.6 \text{ V}, V_{IN} = V_{CC}$	-10	_	10	
I _{IL}	Low level input current	G, \overline{G} and TTL inputs $V_{CC} = 3.6 \text{ V}, V_{IN} = 0$			10	μΑ
C _{IN}	Input capacitance			3		pF

Electrical characteristics RHFLVDS31A

Symbol Parameter Test conditions Min. Тур. Max. Unit Propagation delay time, high to 0.5 1.5 t_{PHLD} low output Propagation delay time, low to 0.5 1.5 t_{PLHD} high output Refer to Figure 4 ns Differential output signal rise 8.0 t_r Differential output signal fall 8.0 t f Channel-to-channel skew⁽²⁾ t_{SK1} 0.28 Chip-to-chip skew (3)(4) 0.7 t_{SK2} Differential skew⁽⁵⁾ 0.3 t_{SKD} (t_{PHLD}-t_{PLHD}) Propagation delay time, high 2.8 t_{PHZ} level to high impedance output Load: refer to Figure 4 ns Propagation delay time, low 2.8 t_{PLZ} level to high impedance output Propagation delay time, high 2.5 t_{PZH} impedance to high level output Propagation delay time, high t_{PZL} 2.5 impedance to low level output

Table 7. Electrical characteristics (continued)

- 4. Guaranteed by design.
- 5. t_{SKD} is the maximum delay time difference between t_{PHLD} and t_{PLHD} (see *Figure 4*).

Cold sparing

The RHFLVDS31A features a cold spare input and output buffer. In high reliability applications, cold sparing enables a redundant device to be tied to the data bus with its power supply at 0 V (V_{CC} = GND) without affecting the bus signals or injecting current from the I/Os to the power supplies. Cold sparing also allows redundant devices to be kept powered off so that they can be switched on only when required. This has no impact on the application. Cold sparing is achieved by implementing a high impedance between the I/Os and V_{CC} . ESD protection is ensured through a non-conventional dedicated structure.

Fail-safe

In many applications, inputs need a fail-safe function to avoid an uncertain output state when the inputs are not connected properly. In case of TTL floating inputs, the LVDS outputs remain in a stable logic-high state.

8/15 DocID025370 Rev 4

^{1.} All pins except pin under test and $V_{\rm CC}$ are floating.

t_{SK1} is the maximum delay time difference between all outputs of the same device (measured with all inputs connected together).

t_{SK2} is the maximum delay time difference between outputs of all devices when they operate with the same supply voltage, at the same temperature.

RHFLVDS31A Test circuit

6 Test circuit

Figure 3. Voltage and current definition

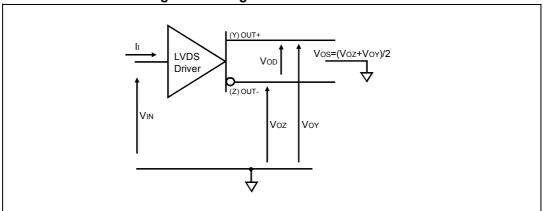
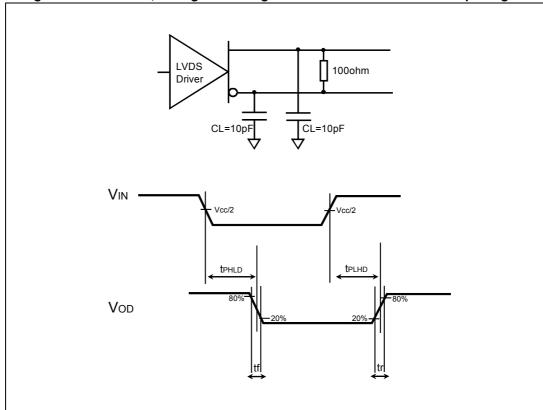


Figure 4. Test circuit, timing and voltage definitions for differential output signal



- 1. All input pulses are supplied by a generator with the following characteristics: t_r or $t_f \le 1$ ns, f = 1 MHz, $Z_O = 50 \Omega$, and duty cycle = 50%.
- 2. The product is guaranteed in test with CL = 10 pF

Test circuit RHFLVDS31A

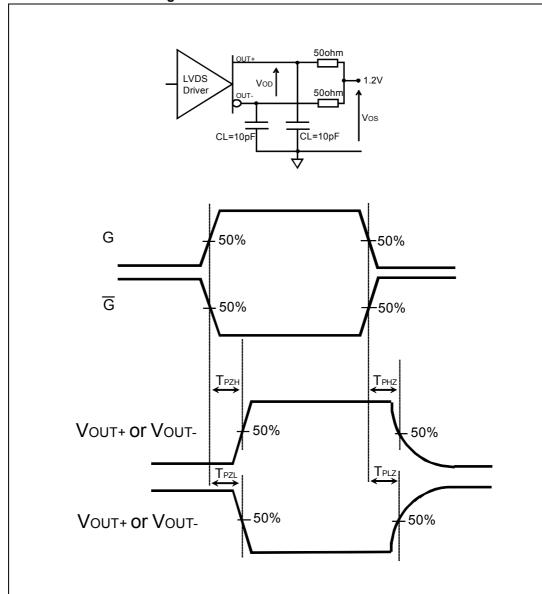


Figure 5. Enable and disable waveform

^{1.} All input pulses are supplied by a generator with the following characteristics: t_r or $t_f \le 1$ ns, t_G or $t_G = 500$ kHz, and pulse width G or $t_G = 500$ ns.

^{2.} The product is guaranteed in test with CL = 10 pF

RHFLVDS31A Package information

7 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK® is an ST trademark.



Package information RHFLVDS31A

7.1 Ceramic Flat-16 package information

Figure 6. Ceramic Flat-16 package mechanical drawing

1. The upper metallic lid is electrically connected to ground.

Table 8. Ceramic Flat-16 package mechanical data

			Dime	nsions		
Ref.		Millimeters			Inches	
	Min.	Тур.	Max.	Min.	Тур.	Max.
Α	2.31		2.72	0.091		0.107
b	0.38		0.48	0.015		0.019
С	0.10		0.18	0.004		0.007
D	9.75		10.13	0.384		0.399
E	6.75		7.06	0.266		0.278
E2		4.32			0.170	
E3	0.76			0.030		
е		1.27			0.050	
L	6.35		7.36	0.250		0.290
Q	0.66		1.14	0.026		0.045
S1	0.13			0.005		

Ordering information 8

Table 9. Order codes

Order code	Description	Temp. range	Package	Marking ⁽¹⁾	Packing
RHFLVDS31AK1	Engineering model	-55 °C to	Ceramic Flat-16	RHFLVDS31AK1	Strip pack
RHFLVDS31AK01V	QML-V flight	125 0	i iat-10	5962F9865107VZC	

- Specific marking only. Complete marking includes the following:
 SMD pin (on QML-V flight only)
 ST logo

 - Date code (date the package was sealed) in YYWWA (year, week, and lot index of week)

 - QML logo (Q or V)Country of origin (FR = France).

Note:

Contact your ST sales office for information regarding the specific conditions for products in die form and QML-Q versions.

Shipping information 9

Date code

The date code is structured as follows:

- Engineering model: EM xyywwz
- QML flight model: FM yywwz

Where:

x = 3 (EM only), assembly location Rennes (France)

yy = last two digits of the year

ww = week digits

z = lot index of the week

Revision history RHFLVDS31A

10 Revision history

Table 10. Document revision history

Date	Revision	Changes
29-Oct-2013	1	Initial release
30-Oct-2014	2	 Updated production status and marking information relative to order code RHFLVDS31AK01V in Table 1: Device summary and Table 9: Order codes. Changed title of Section 4 to "Radiation" and moved Electrical characteristics to Section 5.
04-Mar-2015	3	Added V _{OUT} to Table 4: Absolute maximum ratings.
28-Apr-2017	4	Table 1: Device summary: added mass value

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